

International Workshop on Semiconductor Pixel Detectors for Particles and Imaging (PIXEL2018)

Tuesday, 11 December 2018

X-ray system: (M. Idzik) - Activity Center (14:10 - 15:50)

time	[id] title	presenter
14:10	[52] Calibration of the AGIPD detector system at the European XFEL	POEHLSEN, Jennifer
14:35	[45] EIGER: High frame rate pixel detector for synchrotron and electron microscopy applications	TINTI, Gemma
15:00	[11] Design of a scientific CCD camera with a large focal plane of 4k x 4k pixels	TANG, Qijie
15:25	[33] Radiation Hardness of a P-Channel Notch CCD Developed for the X-ray CCD Camera onboard the XRISM Satellite	KANEMARU, Yoshiaki